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Class	Subclass	Date	Examiner
710	306,308,1 00,305	7/22/2004	τv

INT	ERFERENC	CE SEARCH	ED
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710	306	8/21/0	w
710	308	8/21/05	w

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EAST and NPL database search, USPAT,EPO,PGPUB,JPO,DERWENT JBM-TDB.	7/22/2004	τv
ypolak Semb	8/21/05	w

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Part of Paper No. 07232004